



PATENT 8075-1014

IN THE U.S. PATENT AND TRADEMARK OFFICE

Tsuguo FUKUDA et al. Applicants:

Confirmation: 4391

Serial No.: 10/551,113

1743 Art Unit:

Filed:

Sept. 28, 2005

Examiner: Not assigned

For:

METHOD FOR ANALYZING IMPURITIES (COLOR CENTERS) OF FLUORIDE AND PROCESS FOR PRODUCING MATERIAL FOR

GROWING SINGLE CRYSTAL

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents

September 1, 2006

P.O. Box 1450

Alexandria, VA 22313-1450

Sir:

In compliance with Rules 1.97 and 1.98, and in fulfillment of the duty of disclosure under Rule 1.56, included with the attached Form PTO-1449 is the English language translation of the International Preliminary Examination Report (IPER), together with copies of two references that were not cited in the International Search Report included with the Information Disclosure Statement (IDS) filed with the present application on September 28, 2005.

The Examiner is courteously requested to initial and return a copy of the attached Form PTO-1449 to confirm consideration of the references and their entry into the record.

Respectfully submitted,

YOUNG & THOMPSON

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BC:rk

INFORMATION DISCLOSURE CITATION IN AN APPLICATION				8075-1014		10/551,113			
				Applicant: Tsuguo FUKUDA, et al.					
(Use several sheets if necessary) SER U.S. PATEN				Filing Date: September 28, 2005		Group Art Unit: 1743			
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^{*} English language abstract provided for the Examiner's convenience